

App	licati	on/C	ontro	l No.

10/680,303

Examiner Philip H. Leung Applicant(s)/Patent under Reexamination

TAKAGI ET AL.

Art Unit

3742

ISSUE CLASSIFICATION													
	SINAL		CROSS REFERENCE(S)										
CLASS SUBCLASS			CLASS			SUBCLASS (ONE SUBCLASS				S PER BLO	OCK)		
219 619			219	672		676							
INTERNATIONAL CLASSIFICATION			399	328		330							
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(Legavine	sti un	nents Examiner) (Date)		(Pili	nary Exam	mer)	(Da	te)		1		(a) &
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